MSKSEMI 美森科













ESD

S

MOV

GDT

PLED

DSS32-MS THRU DSS320-MS

Product specification





Features

- Low profile package
- Ideal for automated placement
- Guardring for overvoltage protection
- Low power losses, high efficiency
- High forward surge capability
- Meets MSL level 1, per J-STD-020, LF maximum peak of 260 °C

Typical Applications

For use in low voltage high frequency inverters, freewheeling, DC/DC converters, and polarity protection applications.

MECHANICAL DATA

Package: SOD-123FL
Molding compound meets UL 94 V-0 flammability
rating, RoHS-compliant, halogen-free

- Terminals: Tin plated leads, solderable per J-STD-002 and JESD22-B102
- Polarity: Cathode line denotes the cathode end

Reference News

SOD-123FL	Schematic Diagram

Marking

DSS32-MS	DSS33-MS	DSS34-MS	DSS35-MS	DSS36-MS
K32	K33	K34	K35	K36
DSS38-MS	DSS310-MS	DSS315-MS	DSS320-MS	
K38	K310	K315	K320	

Maximum Ratings (Ta=25 ℃ Unless otherwise specified)

PARAMETER	SYMBOL	UNIT	DSS32 -MS	DSS33 -MS	DSS34 -MS	DSS35 -MS	DSS36 -MS	DSS38 -MS	DSS310 -MS	DSS315 -MS	DSS320 -MS
Repetitive peak reverse voltage	VRRM	V	20	30	40	50	60	80	100	150	200
ଷ୍ଟ୍ରେମ୍ବର ହେଉଆଁ ହେଉ ହ୍ୟାନ୍ୟ istamee tload, Ta (FIG.1)	IO	A	3.0								
Surge(non-repetitive)forward current @60Hz half-sine wave,1 cycle, Tj=25℃	IFSM	Α	65								
Storage temperature -55 ~+150	Tstg	$^{\circ}$	-55 ~+150								
Junction temperature	Tj	°C	-55 ~+150 -55 ~+175								
Typical Junction Capacitance measured at 1MHz and Applied on 4.0VD.C	Cj	pF	165								



Electrical Characteristics (Ta=25 °C Unless otherwise specified)

PARAMETER	SYMBOL	UNIT	TEST CONDITIONS	DSS32 -MS	DSS33 -MS	DSS34 -MS	DSS35 -MS	DSS36 -MS	DSS38 -MS	DSS310 -MS	DSS315 -MS	DSS320 -MS
Maximum instantaneous forward voltage drop per diode	VF	V	IFM=3.0A	0.55		0.70		0.85		0.0	95	
Maximum DC reverse current at rated DC blocking voltage	IRRM	mA	Ta=25°C	0.5			.5			0.	1	
per diode @ VRM=VRRM			Ta=100°C	10					5			

Thermal Characteristics (Ta=25°C Unless otherwise specified)

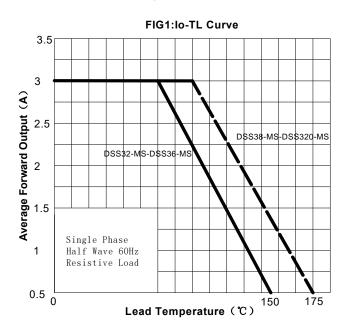
PARAMETER	SYMBOL	UNIT	DSS32 -MS	DSS33 -MS	DSS34 -MS	DSS35 -MS	DSS36 -MS	DSS38 -MS	DSS310 -MS	DSS315 -MS	DSS320 -MS
Thermal Resistance	R0J-A	°C/W	70 ¹)								
	R0J-L		25 ¹⁾								

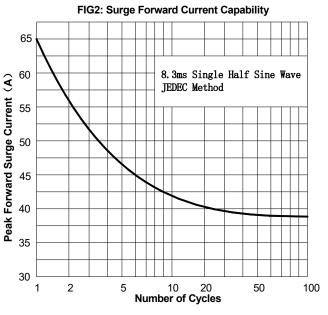
Note:

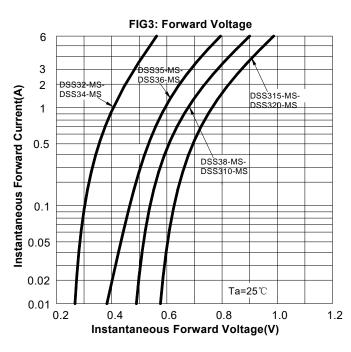
(1) Thermal resistance between junction and ambient and between junction and lead mounted on P.C.B with 3mm*3mm copper pad areas.

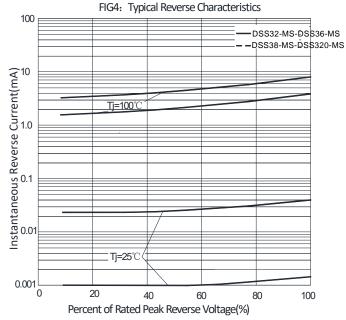


Characteristics (Typical)



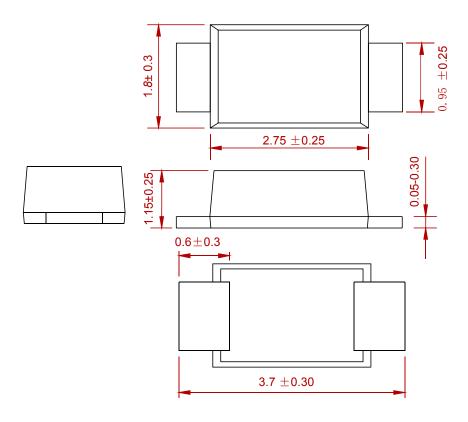






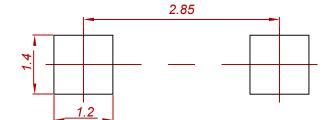


PACKAGE MECHANICAL DATA



Dimensions in millimeters

Suggested Pad Layout



Note:

- 1. Controlling dimension:in millimeters.
- 2.General tolerance:±0.05mm.
- 3. The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
DSS32-MS THRU DSS320-MS	SOD-123FL	3000



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